Serial No.

FIELD EMISSION SCANNING ELECTRON MICROSCOPE (FE-SEM) LABORATORY CENTRAL RESEARCH FACILITY INDIAN INSTITUTE OF TECHNOLOGY (ISM), DHANBAD

Date:

-	given overlear before init	ing up this form and put a tick ($$)	in appropriate box
I wish to get (in words) number	r of samples be examined/analyze	d. The nature of samples
is Metallic (), Ceramic (), Polymer/Rubber () Semiconductor (), ICs (), Magnetic (),
Composites () or others ()		
(If others please elaborate:)
I wish to study the sample using	the FESEM imaging facil	ity [], EDAX* point analysis	[] or mapping [],
STEM [], EBSD [], CL [] for my sample/s.		
*I need to analyze samples by th	e Energy Dispersive Spec	etroscopy (EDAX) Micro analysis	System. I am interested
in: Qualitative microanalysis: () Quantitative microana	alysis () X-ray area mapping	() or Line scan (line
mapping): ()			
I need gold ()/carbon ()/Pl	atinum coating (): (Ye	s/No) (For non-cond	ucting samples)
Please allot me slots ofhou	ur/s (each slot is l hour), th	e estimated charge for the work is	 s₹
		Name of Supervisor	
Dept./Centre		_	
Signature of HOD/HOC/Guide/P	I/Profin-Charge	Sig	gnature of the user
Details of analysis Charges:			<u> </u>
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Signature of the Operator

Signature of the user

INFORMATION FOR USERS

The charges for the FESEM, EDAX, EBSD, STEM and CL as follows (per hour long slot including sample preparation) in ₹:

	FESEM Imaging (₹)	EDAX Point analysis (₹)	EDAX Mapping (₹)	EBSD# (per sample in ₹)	STEM# (₹)	CL# (₹)
For users of IIT (ISM)	750	750	750	1000	1000	1000
For outside R&D* and Academics	1250	1250	1250	3000	3000	3000
For Industry*	3500	3500	3500	5000	5000	5000

[No TAX is required for user of IIT (ISM)]

#For EBSD and STEM, sample must be prepared by the user.

Booking Rules for FE-SEM

- 1) The microscope is available for booking every week as follows: Total 10 halves/sessions in 5 working days (Monday Friday). Each session is for three hours or 3 slots (including sample mounting, sample insertion, venting and data collection time). At best 5 to 6 samples can be inserted in the SEM in each slot.
- 2) Magnetic samples may declare properly.
- 3) Samples require C/Au/Pt coating must be mentioned in the booking form clearly.
- 4) Moisture within the sample is not allowed for study. Hydrated samples must be dried properly before run.
- 5) Deadline for submission of slot booking forms is Thursday (up to 3 PM) of the previous week.
- 6) Allotment of slot will be notified at 4 PM on the next day (i.e. Friday).
- 7) One can get a maximum of 2 consecutive slots at a time (approximately two hours). Users who could not obtain a booking in the preceding fortnight will be given preference.
- 8) All payment must be made prior to booking of the slot and true copy of the payment slip (for deposit in IIT (ISM) cash counter in the head of **CRF-FESEM**) or original DD [must be drawn in favour of **Registrar, IIT (ISM)**] must be provided with booking form.
- 9) All forms must be forwarded through the concerned HOD, HOC, PI, Guide or Prof.-in-Charge etc. and to be submitted in the FESEM Laboratory.
- 10) In case of power shut down or unforeseen disturbances, any unutilized slot will be subsequently compensated for in the next round of booking.
- All users should inform composition and sample details to the operator and leave a copy of the photographs/results in the laboratory for internal records (log book).
- 12) Generated data will be provided to the user only through the new unused blank CD. No request will be entertain for providing generated data by e-mail, pen drive, external hard disk or any other means. Thus user may bring a new CD for collection of their data.
- All users are sincerely requested to inform the laboratory if any of the results obtained from FE-SEM receive special recognition (publication, award, journal-cover-page, special citation etc.) and leave a copy of their reprint, photograph or award copy with the FE-SEM lab for internal documentation.

^{*}The charges are excluding GST.